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## 1200V, 50A, Trench FS II Fast IGBT

## General Description:

Using NCE's proprietary trench design and advanced FS (Field Stop) second generation technology, the 1200V Trench FSII IGBT offers superior conduction and switching performances, and easy parallel operation;

## Features

- Trench FSII Technology Offering
- Very low $\mathrm{V}_{\mathrm{CE}(\text { sat })}$
- High speed switching
- Positive temperature coefficient in $\mathrm{V}_{\mathrm{CE}(\text { sat })}$
- Very tight parameter distribution
- High ruggedness, temperature stable behavior


Schematic diagram

## Application

- Inverters
- Motor drives
- Converter


## Package Marking and Ordering Information

| Device | Device Package | Device Marking |
| :---: | :---: | :---: |
| NCE50TD120BT | TO-247 | NCE50TD120BT |



TO-247

## Absolute Maximum Ratings ( $\mathrm{Tc}=25^{\circ} \mathrm{C}$ unless otherwise noted)

| Symbol | Parameter | Value | Units |
| :---: | :---: | :---: | :---: |
| Vces | Collector-Emitter Voltage | 1200 | V |
| VGes | Gate- Emitter Voltage | $\pm 30$ | V |
| Ic | Collector Current | 100 | A |
|  | Collector Current @Tc = $100^{\circ} \mathrm{C}$ | 50 | A |
| Icplus | Pulsed Collector Current, $\mathrm{t}_{\mathrm{p}}$ limited by $\mathrm{T}_{\mathrm{jmax}}$ | 150 | A |
| - | turn off safe operating area, $\mathrm{V}_{\text {CE }}=1200 \mathrm{~V}, \mathrm{Tj}=150^{\circ} \mathrm{C}$ | 150 | A |
| $\mathrm{I}_{\mathrm{F}}$ | Diode Continuous Forward Current @Tc $=100^{\circ} \mathrm{C}$ | 50 | A |
| Ifm | Diode Maximum Forward Current | 150 | A |
| PD | Power Dissipation @ $\mathrm{T}_{\mathrm{c}}=25^{\circ} \mathrm{C}$ | 535 | W |
|  | Power Dissipation @ $\mathrm{T}_{\mathrm{C}}=10{ }^{\circ} \mathrm{C}$ | 268 | W |
| $\mathrm{T}_{\mathrm{J},} \mathrm{T}_{\text {stg }}$ | Operating Junction and Storage Temperature Range | -55 to +175 | ${ }^{\circ} \mathrm{C}$ |
| TL | Maximum Temperature for Soldering | 260 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{tsc}_{\text {c }}$ | Short circuit withstand time $\mathrm{V}_{\mathrm{GE}}=15.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{CC}} \leqslant 600 \mathrm{~V}$, Allowed number of short circuits<1000Time between short circuits: $\geqslant 1.0 \mathrm{~s}, \mathrm{~T}_{\mathrm{j}} \leqslant 150^{\circ} \mathrm{C}$ | 10 | us |

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## Thermal Characteristic

| Symbol | Parameter | Value | Units |
| :---: | :--- | :---: | :---: |
| $R_{\text {өコc }}$ | Thermal Resistance，Junction to case for IGBT | 0.28 | 0.5 |
| $R_{\text {өコс }}$ | Thermal Resistance，Junction to case for Diode | 40 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $R_{\text {өJA }}$ | Thermal Resistance，Junction to Ambient | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |  |

Electrical Characteristics（ $\mathrm{Tc}=25^{\circ} \mathrm{C}$ unless otherwise noted）

| Symbol | Parameter | Test Conditions |  | Value |  |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Min． | Typ． | Max． |  |
| Static Characteristics |  |  |  |  |  |  |  |
| $V_{\text {（BR）CES }}$ | Collector－Emitter Breakdown Voltage | $\mathrm{V}_{\mathrm{GE}}=0 \mathrm{~V}, \mathrm{ICE}=1 \mathrm{~mA}$ |  | 1200 | －－ | －－ | V |
| Ices | Collector－Emitter Leakage Current | $\mathrm{V}_{\mathrm{GE}}=0 \mathrm{~V}, \mathrm{~V}_{\text {cE }}=1200 \mathrm{~V}$ |  | －－ | －－ | 5 | uA |
| IGES（F） | Gate to Emitter Forward Leakage | $\mathrm{V}_{\mathrm{GE}}=+30 \mathrm{~V}, \mathrm{~V}_{\text {CE }}=0 \mathrm{~V}$ |  | －－ | －－ | 200 | nA |
| $\mathrm{IGES}_{(\mathrm{R})}$ | Gate to Source Reverse Leakage | $\mathrm{V}_{\mathrm{GE}}=-30 \mathrm{~V}, \mathrm{~V}_{\text {ce }}=0 \mathrm{~V}$ |  | －－ | －－ | 200 | nA |
| $\mathrm{V}_{\mathrm{CE} \text {（sat）}}$ | Collector－Emitter Saturation Voltage | $\begin{gathered} \mathrm{I}_{\mathrm{C}}=50 \mathrm{~A} \\ \mathrm{~V}_{\mathrm{GE}}=15 \mathrm{~V} \end{gathered}$ | $\mathrm{Tj}=25^{\circ} \mathrm{C}$ | －－ | 1.55 | 1.8 | V |
|  |  |  | $\mathrm{Tj}=150^{\circ} \mathrm{C}$ | －－ | 1.8 | －－ | V |
| $V_{\text {GE（th }}$ | Gate Threshold Voltage | $\mathrm{I}_{\mathrm{C}}=1 \mathrm{~mA}, \mathrm{~V}_{\mathrm{CE}}=\mathrm{V}_{\mathrm{GE}}$ |  | 5.0 | －－ | 6.5 | V |
| $\mathrm{IC}(\mathrm{SC})$ | Short circuit collector current Max． 1000 short circuits Time between short circuits： $\geqslant 1.0 \mathrm{~s}$ | $\begin{aligned} & V_{G E}=15 \mathrm{~V}, \mathrm{~V}_{\mathrm{CC}} \leqslant 600 \mathrm{~V}, \\ & \mathrm{tsc} \leqslant 10 \mathrm{us}, \mathrm{Tj} \leqslant 150^{\circ} \mathrm{C} \end{aligned}$ |  | －－ | 300 | －－ | A |
| Dynamic Characteristics |  |  |  |  |  |  |  |
| $\mathrm{C}_{\text {ies }}$ | Input Capacitance | $\begin{gathered} \mathrm{V}_{\mathrm{CE}}=30 \mathrm{~V}, \mathrm{~V}_{\mathrm{GE}}=0 \mathrm{~V}, \\ \mathrm{f}=1 \mathrm{MHz} \end{gathered}$ |  | －－ | 6500 | －－ | pF |
| $\mathrm{Coses}^{\text {a }}$ | Output Capacitance |  |  | －－ | 218 | －－ |  |
| Cres | Reverse Transfer Capacitance |  |  | －－ | 180 | －－ |  |
| $\mathrm{Q}_{\mathrm{g}}$ | Total Gate Charge | $\begin{gathered} \mathrm{V}_{\mathrm{cc}}=960 \mathrm{~V}, \mathrm{I}_{\mathrm{C}}=50 \mathrm{~A}, \\ \mathrm{~V}_{\mathrm{GE}}=15 \mathrm{~V} \end{gathered}$ |  | －－ | 381 | －－ | nC |
| $\mathrm{Q}_{\mathrm{ge}}$ | Gate to Emitter Charge |  |  | －－ | 46 | －－ |  |
| $\mathrm{Q}_{\mathrm{gc}}$ | Gate to Collector Charge |  |  | －－ | 195 | －－ |  |
| Switching Characteristics |  |  |  |  |  |  |  |
| td （ON） | Turn－on Delay Time | $\begin{gathered} \mathrm{V}_{\mathrm{CE}}=600 \mathrm{~V}, \mathrm{I}_{\mathrm{C}=}=50 \mathrm{~A}, \\ \mathrm{~V}_{\mathrm{GE}}=0 / 15 \mathrm{~V}, \mathrm{R}_{\mathrm{g}}=8 \Omega \\ \text { Inductive Load } \end{gathered}$ |  | －－ | 19 | －－ | ns |
| tr | Rise Time |  |  | －－ | 17 | －－ |  |
| td（OFF） | Turn－Off Delay Time |  |  | －－ | 170 | －－ |  |
| $\mathrm{tf}_{f}$ | Fall Time |  |  | －－ | 18 | －－ |  |
| Eon | Turn－On Switching Loss |  |  | －－ | 2.8 | －－ | mJ |
| Eoff | Turn－Off Switching Loss |  |  | －－ | 2.0 | －－ |  |
| $\mathrm{E}_{\text {ts }}$ | Total Switching Loss |  |  | －－ | 4.8 | －－ |  |

## Electrical Characteristics of the Diode（Tc＝ $25^{\circ} \mathrm{C}$ unless otherwise specified）：

| Symbol | Parameter | Test Conditions | Rating |  |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min． | Typ． | Max． |  |
| $V_{\text {FM }}$ | Diode Forward Voltage | $\mathrm{I}_{\mathrm{F}=50 \mathrm{~A}}$ | －－ | 2.2 | 2.8 | V |
| Trr | Reverse Recovery Time | $\begin{gathered} \mathrm{l}=25 \mathrm{~A}, \\ \mathrm{di} / \mathrm{dt}=700 \mathrm{~A} / \mathrm{us} \end{gathered}$ | －－ | 150 | －－ | ns |
| IRRM | Diode Peak Reverse Recovery Current |  | －－ | 10 | －－ | A |
| Qrr | Reverse Recovery Charge |  | －－ | 2.2 | －－ | uC |
| Pulse width $\operatorname{ttp} \leq 380 \mu \mathrm{~s}, \delta \leq 2 \%$ |  |  |  |  |  |  |

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## Test Circuit

1) Gate Charge Test Circuit


## Switching characteristics

1) Definition of switching times

2) Definition of switching losses

3) Definition of diode switching characteristics


## Typical Electrical and Thermal Characteristics

Figure 1 Output Characteristics


Figure $3 \mathrm{~V}_{\mathrm{CE}(\text { sat）}}$ vs．Case Temperature


Figure 5 Capacitance Characteristics


Figure 2 Transfer Characteristics


Figure 4 Saturation Voltage vs． $\mathrm{V}_{\mathrm{GE}}$


Figure 6 Gate Charge Wave Form


## TO－247 Package Information



| Symbol | Dimensions In Millimeters |  | Dimensions In Inches |  |
| :---: | :---: | :---: | :---: | :---: |
|  | Min． | Max． | Min． | Max． |
| A | 4.90 | 5.10 | 0.193 | 0.201 |
| A1 | 2.31 | 2.51 | 0.091 | 0.099 |
| A2 | 1.9 | 2.1 | 0.075 | 0.083 |
| b | 1.16 | 1.26 | 0.046 | 0.050 |
| b2 | 1.96 | 2.06 | 0.077 | 0.081 |
| b4 | 2.96 | 3.06 | 0.117 | 0.120 |
| b6 | - | 2.25 | - | 0.089 |
| b7 | - | 3.25 | 0.023 | 0.128 |
| C | 0.59 | 0.66 | 0.823 | 0.026 |
| D | 20.90 | 16.85 | 0.640 | 0.831 |
| D1 | 16.25 | 1.35 | 0.041 | 0.663 |
| D2 | 1.05 | 15.90 | 0.618 | 0.053 |
| E | 15.70 | 13.50 | 0.516 | 0.626 |
| E1 | 13.10 |  |  | 0.531 |
| e |  | 20.10 | 0.214 BSC |  |
| L | 19.80 | 4.30 | 0.780 | 0.791 |
| L1 | - | 3.60 | 0.276 | 0.169 |
| P | 3.40 | 7.40 | 0.238 | 0.142 |
| P1 | 7.00 | 10.20 | 0.291 |  |
| S | 9.80 |  |  | 0.246 |
|  |  |  |  | 0.402 |


#### Abstract

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